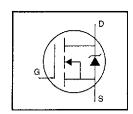
IRF614S

HEXFET® Power MOSFET

- Surface Mount
- Available in Tape & Ree!
- Dynamic dv/dt Rating
- · Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- · Simple Drive Requirements

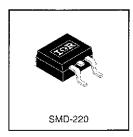


 $V_{DSS} = 250V$ $R_{DS(on)} = 2.0\Omega$ $I_{D} = 2.7A$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.



Absolute Maximum Ratings

	Parameter	Max.	Units	
In @ Tc = 25°C	Continuous Drain Current, V _{GS} @ 10 V	2.7		
I _D @ T _C = 100°C	Continuous Drain Current, VGS @ 10 V	1.7	Α	
Івм	Pulsed Drain Current ①	8.0		
P _D @ T _C = 25°C	Power Dissipation	36	w	
PD @ TA = 25°C	Power Dissipation (PCB Mount)**	3.1		
	Linear Derating Factor	0.29	W/°C	
	Linear Derating Factor (PCB Mount)**	0.025		
Vgs	Gate-to-Source Voltage	±20	V	
Eas	Single Pulse Avalanche Energy ②	61	mJ	
I _{AB}	Avalanche Current ①	2.7	Α	
EAR	Repetitive Avalanche Energy ①	3.6	mJ	
dv/dt	Peak Diode Recovery dv/dt ®	4.8	V/ns	
TJ, TSTG	Junction and Storage Temperature Range	-55 to +150	∘c	
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)		

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
Reac	Junction-to-Case	· —	_	3.5	
R _{0JA}	Junction-to-Ambient (PCB mount)**			40	°C/W
Reja	Junction-to-Ambient	_	-	62	

^{**} When mounted on 1" square PCB (FR-4 or G-10 Material).
For recommended footprint and soldering techniques refer to application note #AN-994.



Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min,	Тур.	Max.	Units	Test Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	250	_	_	V	V _{GS} =0V, I _D = 250μA
ΔV _{(BR)DSS} /ΔT _J	Breakdown Voltage Temp. Coefficient	_	0.39	_	V/°C	Reference to 25°C, ln= 1mA
Rps(on)	Static Drain-to-Source On-Resistance	_	_	2.0	Ω	V _{GS} =10V, I _D =1.6A @
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	٧	V _{DS} =V _{GS} , l _D = 250μA
Qfs	Forward Transconductance	0.90			S	V _{DS} =50V, I _D =1.6A €
	B : 1.0	_	_	25		V _{DS} =250V, V _{GS} =0V
loss	Drain-to-Source Leakage Current	_	_	250	μА	V _{DS} =200V, V _{GS} =0V, T _J =125°C
1	Gate-to-Source Forward Leakage			100	пА	V _{GS} =20V
lgss	Gate-to-Source Reverse Leakage	-		-100	I IIA	V _{GS} =-20V
Qg	Total Gate Charge		_	8.2		I _D =2.7A
Q_{gs}	Gate-to-Source Charge	_		1.8	nC	V _{DS} =200V
Q _{gd}	Gate-to-Drain ("Miller") Charge	-	_	4.5		V _{GS} =10V See Fig. 6 and 13 ⊕
t _{a(or)}	Turn-On Delay Time	_	7.0			V _{DD} =125V
tr	Rise Time		7.6		ns	I _D =2.7A
t _{c(off)}	Turn-Off Delay Time		16		""	$R_G=24\Omega$
t _f	Fall Time	_	7.0	_	i	R _D =45Ω See Figure 10 @
L _D	Internal Drain Inductance	-	4.5	_	: - nH	Between lead, 6 mm (0.25in.)
Ls	Internal Source Inductance	_	7.5		1111	from package and center of die contact
Ciss	Input Capacitance	-	140			V _{GS} =0V
Coss	Output Capacitance	Ι —	42	_	pF	V _{DS} = 25V
Crss	Reverse Transfer Capacitance	_	9.6	-		f=1.0MHz See Figure 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current (Body Diode)	-	_	2.7	Α	MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①	_	_	8.0	^	integral reverse p-n junction diode.
V _{SD}	Diode Forward Voltage		_	2.0	٧	T _J =25°C, I _S =2.7A, V _{GS} =0V ④
t _{rr}	Reverse Recovery Time	_	190	390	ns	T _J =25°C, I _F =2.7A
Qrr	Reverse Recovery Charge		0.64	1.3	μC	di/dt=100A/μs ⊚
ton	Forward Turn-On Time	Intrinsi	Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+Lb)			

Notes:

- Repetitive rating; pulse width limited by max, junction temperature (See Figure 11)
- ③ Isp≤2.7A, di/dt≤65A/μs, Vpp≤V(βR)bss, TJ≤150°C
- ② V_{DD}=50V, starting T_J=25°C, L=13mH R_G=25Ω, I_{AS}=2.7A (See Figure 12)
- ④ Pulse width ≤ 300 μ s; duty cycle ≤2%.

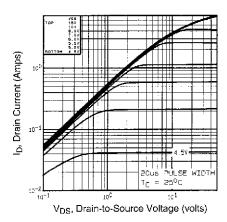


Fig 1. Typical Output Characteristics, T_C=25°C

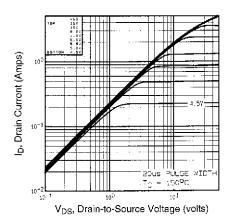


Fig 2. Typical Output Characteristics, T_C=150°C

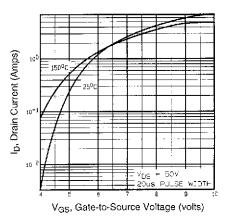


Fig 3. Typical Transfer Characteristics

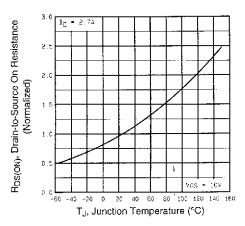


Fig 4. Normalized On-Resistance Vs. Temperature

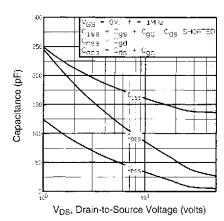


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

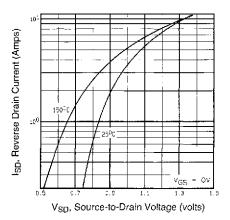


Fig 7. Typical Source-Drain Diode Forward Voltage

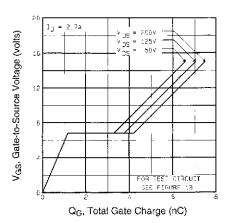


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

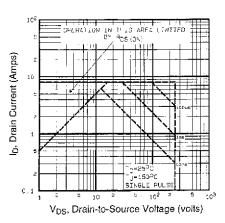


Fig 8. Maximum Safe Operating Area

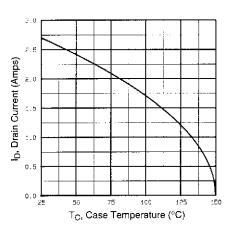


Fig 9. Maximum Drain Current Vs. Case Temperature

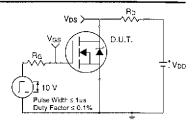


Fig 10a. Switching Time Test Circuit

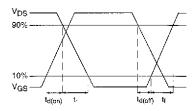


Fig 10b. Switching Time Waveforms

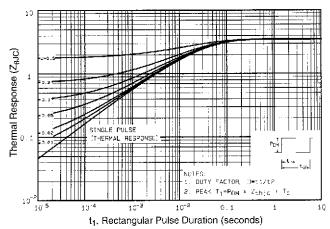


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

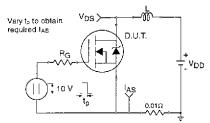


Fig 12a. Unclamped Inductive Test Circuit

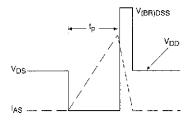


Fig 12b. Unclamped Inductive Waveforms

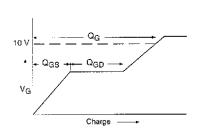


Fig 13a. Basic Gate Charge Waveform

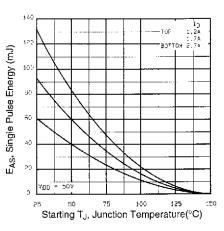


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

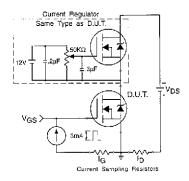


Fig 13b. Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit

Appendix B: Package Outline Mechanical Drawing

Appendix C: Part Marking Information

Appendix D: Tape & Reel Information





Vishay

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